Quantitative modeling of resonant PL in InGaN SQW LEDs

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### Outline

- Motivation: Overview and status of LED modeling tasks
- Self-consistent model for InGaN-SQW LED
- Comparison to reverse bias PL-experiment
- What does the model predict?
- Conclusion



#### **OSRAM Opto Semiconductors**





#### **Our light source: The ThinGaN LED**



Main efficiency issues:

- Series resistance (Rs)
- Light generation (IQE)
- Light extraction (EQE)
- Conversion (Lm/W)
- Thermal resistance (RTh)

Goal of modeling: Quantitative description and optimization of entire system



# Overview modeling tasks for InGaN LEDs: <u>Chip properties</u>





#### **Overview modeling tasks for InGaN LEDs:** <u>Internal properties</u>



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## Proposed Approach

#### Theory



#### Experiment



#### Simple but predictive model





#### Introduction: Quantum well in piezoelectric materials

**No piezo-fields:** (InGaAIP, AlGaAs)



- Good overlap of electrons and holes
- No extra barriers

With piezo-fields: (InGaN, AIGaN along [0001] axis) Injection barrier due to **Piezoelectric charges** Electrons and holes separated: 

#### What are the consequences of the piezoelectric fields ?





#### QW-alloy profile obtained from DALI-measurement



#### • Experiment: Gaussian alloy profile





#### **Piezoelectric charges**



Gaussian alloy profile → continous distribution of the piezoelectric charges
Maximum electric field inside QW ~ 3 [MV/cm]



#### Schematic picture of bandstructure in PL



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#### **Relevant transport processes for resonant PL**





#### **Application to real LED-structure**



**Band structure** 

**Doping vs. piezoelectric charges** 

Green LED: Piezoelectric charges dominant
 → Complete screening of piezoelectric charges via doping not realistic.



#### Physics: Quantum confined Stark effect (QCSE)



• Peak shift follows change in overlap (QCSE)



#### **Compare to experiment: Peak shift**





#### **Compare to experiment: Decay time**



Decay rate ∞ electron-hole overlap
Strong influence of piezoelectric field





#### Screening @ forward bias (10mA)



High carrier densities (>2E19) due to slow decay rates.
Only partial screening of piezoelectric charges



#### Forward bias: Screening of piezoelectric fields



Forward bias peak shift: screening





#### **Prediction: Compare polar – nonpolar peakshift**



Low currents: 50nm shorter peak wavelength without piezoelectric fields
High currents: Peaks approach each other due to screening piezoelectric fields

 $\rightarrow$  Can the model predict the absorption and emission?

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#### **Compare to experiment: emission and absorption**



Simple single particle model with artificial broadening shows good agreement

→ How does Indium content influence absorption and Stokes-shift?

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#### **Prediction:** absorption tail vs. Indium content



Absorption tail strongly increases with increasing indium content





#### **Prediction: Stokes-shift vs. Indium content**



Stokes shift strongly increases with increasing indium content

 $\rightarrow$  How does the Indium content influence the gain?



#### **Compare to experiment: Peak gain vs. current**

**Experimental gain** 

50 5000 4500 (a) gain [1/cm] 40 4000 Mode gain (cm<sup>-1</sup>) 3500 30 3000 2500 480nm 2000 20 375 nm 384nm Peak 1500 407 nm 1000 440 nm -500 -470 nm 0 0 2 3 n 10 8 0 2 4 6 Current density (kA/cm<sup>2</sup>) Current density [kA/cm<sup>2</sup>] K. Kojima, Opt. Express 15, 7730 (2007)

# Different gain evolution as function of current for different Indium contents Qualitative agreement with model

Calculated gain



#### Conclusion

Successful collaboration between theory and experiment

**Quantitative prediction of:** 

- peak-shift (EL and reverse bias PL)
- electron-hole overlap
- carrier densities
- absorption and Stokes shift

**Qualitative prediction of:** 

- gain

Quantitative modeling of InGaN structures is possible with 'simple' model



